

<b>Search Notes</b>  	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10659393	ONAMI, YUICHI
	<b>Examiner</b>  Bayat, Ali	<b>Art Unit</b>  2624

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
382	236,232,233,238,250,251	11/26/06	A.B
375	240.14,240.16,240.02,240.2	11/26/06	A.B
348	404.1,416.1, 415.1	11/26/06	A.B
386	52,68,111	11/26/06	A.B

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
EAST( USPGPUB, USPAT; EPO;JPO;DERWENT; IBM-TDB),see the text search history print out, consulted with Wu Jingge.	11/26/06	A.B
IEEE XPLORE	11/26/06	A.B
Inventor name searched	11/26/06	A.B

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>